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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

plication of:

Bruno De Man et al.

Serial No.: 10/7

10/789,539

Filed:

February 27, 2004

For:

METHOD AND SYSTEM FOR IMAGING USING MULTIPLE

OFFSET X-RAY EMISSION POINTS

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Group Art Unit:

2882

Examiner:

Suchecki, Krystyna

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Atty. Docket: 129405-1/YOD/RAR

GERD:0049

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 CERTIFICATE OF MAILING 37 C.F.R. 1.8

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as First Class Mail in an envelope addressed to: Commissioner for Patents, Mail Stop Amendment, P.O. Box 1450, Alexandria, VA 22313-1450, on the date below:

November 9, 2005

Date

Stephanie Shamgar

INTERVIEW SUMMARY MAILED SEPTEMBER 9, 2005

Dear Sir:

As noted in the Response filed August 31, 2005, Applicants thank the Examiner for the interview conducted on August 29, 2005. Furthermore, the Applicants acknowledge the summary of the interview provided by the Examiner in the Interview Summary mailed on September 9, 2005. The summary provided by the Examiner in the September 9, 2005 communication is believed to accurately reflect the substance of referenced interview and the range of subject matter discussed. The Applicants thank the Examiner for this timely summary.

Conclusion

If the Examiner believes that a telephonic interview will help speed this application toward issuance, the Examiner is invited to contact the undersigned at the telephone number listed below.

Respectfully submitted,

Date: November 9, 2005

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